Power MOSFET

30 V, 38 A, Single N-Channel, µ8FL Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC–DC Converters

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Para	Symbol	Value	Unit		
Drain-to-Source Volt	V _{DSS}	30	V		
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current $R_{\theta JA}$		$T_{A} = 25^{\circ}C$ $T_{A} = 80^{\circ}C$	Ι _D	11.7 8.5	A
(Note 1)					
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	PD	2.06	W
Continuous Drain		$T_A = 25^{\circ}C$	I _D	15.8	Α
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		$T_A = 80^{\circ}C$		11.4	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} (\text{Note 1})$	Steady	$T_A = 25^{\circ}C$	PD	3.73	W
Continuous Drain	State	$T_A = 25^{\circ}C$	I _D	7.2	Α
Current R _{0JA} (Note 2)		$T_A = 80^{\circ}C$		5.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	PD	0.78	W
Continuous Drain		T _C = 25°C	I _D	38	Α
Current R _{0JC} (Note 1)		T _C =80°C	1	27	
Power Dissipation $R_{\theta JC}$ (Note 1)	T _C = 25°C		PD	21.5	W
Pulsed Drain Current	T _A = 25°	°C, t _p = 10 μs	I _{DM}	68	A
Current Limited by Pa	ackage	$T_A = 25^{\circ}C$	I _{Dmax}	70	А
Operating Junction an Temperature	T _J , T _{STG}	–55 to +150	°C		
Source Current (Body	۱ _S	19	Α		
Drain to Source DV/D	dV/d _t	7.0	V/ns		
Single Pulse Drain-to Energy ($T_J = 25^{\circ}C$, V L = 0.1 mH, R _{GS} = 25	E _{AS}	22	mJ		
Lead Temperature for (1/8" from case for 10	ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

3. This is absolute maximum rating. Parts are tested at $T_J = 25^{\circ}C V_{qs} = 10 V$,

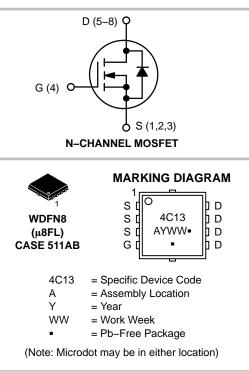
I_L = 15 Apk, E_{AS} = 11 mJ.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	9.4 mΩ @ 10 V	38 A
	14 mΩ @ 4.5 V	30 A



ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4C13NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4C13NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	5.8	
Junction-to-Ambient - Steady State (Note 4)	R_{\thetaJA}	60.8	°C/W
Junction-to-Ambient - Steady State (Note 5)	R_{\thetaJA}	160	°C/W
Junction-to-Ambient - (t \leq 10 s) (Note 4)	$R_{ hetaJA}$	33.5	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 µA		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	$V_{GS} = 0 \text{ V}, I_{D(aval)} = TBD \text{ A},$ $T_{case} = 25^{\circ}\text{C}, t_{transient} = 100 \text{ ns}$		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				14.9		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	
		$V_{DS} = 24 V$	T _J = 125°C			10	μA
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)		• •		-		-	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.3		2.1	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		7.5	9.4	0
		V _{GS} = 4.5 V	I _D = 12 A		11.2	14	mΩ
Forward Transconductance	9fs	V _{DS} = 1.5 V, I	_D = 15 A		40		S
Gate Resistance	R _G	T _A = 25°	٥c		1.0		Ω
CHARGES AND CAPACITANCES		•					
Input Capacitance	C _{ISS}				770		pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 M⊦	lz, V _{DS} = 15 V		443		
Reverse Transfer Capacitance	C _{RSS}				127		
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 1	5 V, f = 1 MHz		0.165		
Total Gate Charge	Q _{G(TOT)}				7.8		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			1.4		1
Gate-to-Source Charge	Q _{GS}				2.9		nC
Gate-to-Drain Charge	Q _{GD}				3.7		1
Gate Plateau Voltage	V _{GP}				3.6		V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			15.2		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

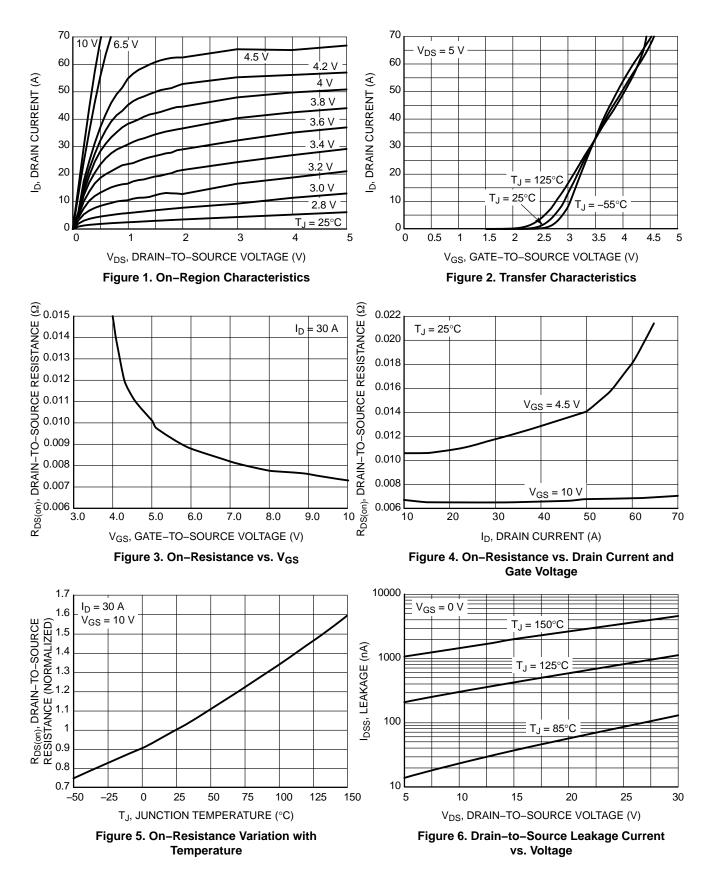
6. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

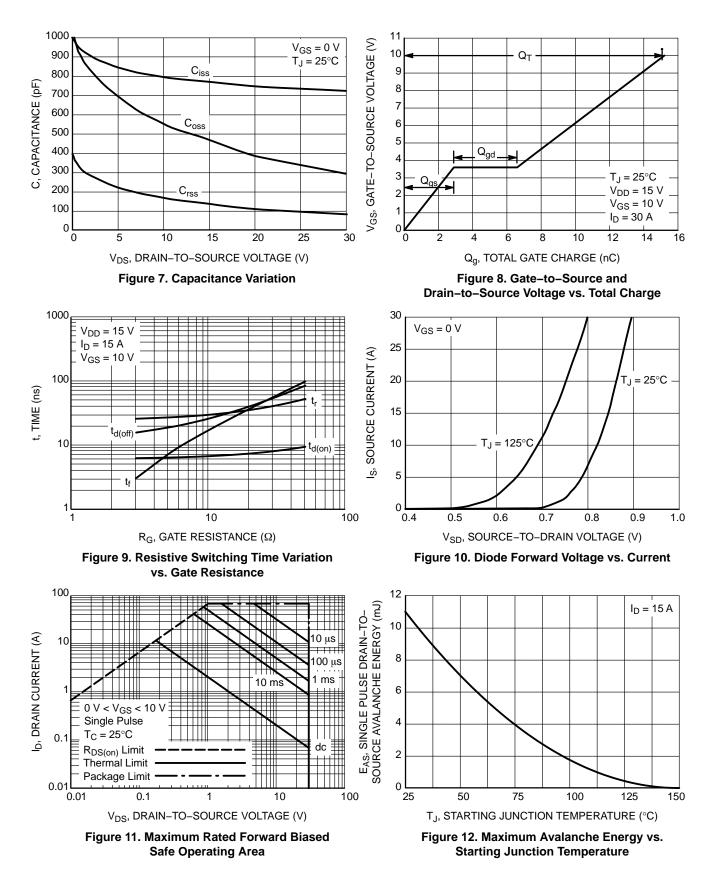
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)	•					
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			9		- ns
Rise Time	tr				35		
Turn–Off Delay Time	t _{d(OFF)}				13		
Fall Time	t _f				5		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			6.0		ns
Rise Time	t _r				26		
Turn-Off Delay Time	t _{d(OFF)}				16		
Fall Time	t _f				3.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, \qquad T_{J} = 25^{\circ}C \\ I_{S} = 30 A \qquad T_{J} = 125^{\circ}C$			0.82	1.1	
					0.69		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 30 A			23.4		
Charge Time	t _a				12.1		ns
Discharge Time	t _b				11.3		
Reverse Recovery Charge	Q _{RR}				9.7		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 6. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 7. Switching characteristics are independent of operating junction temperatures.

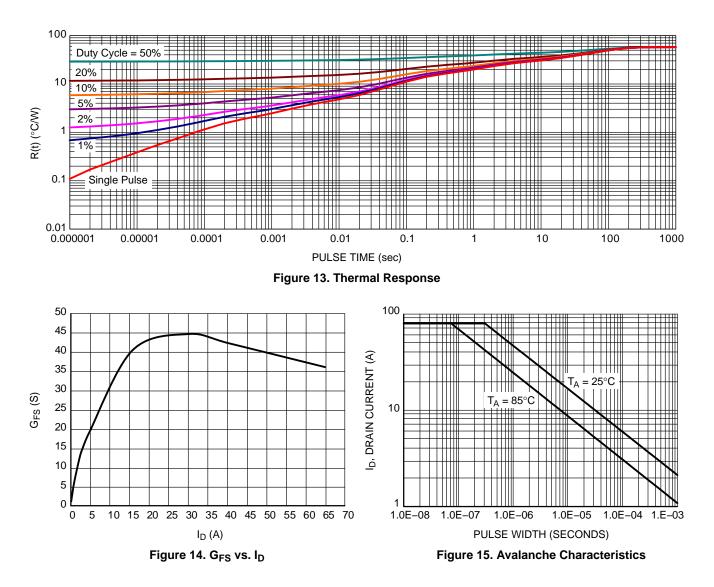
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

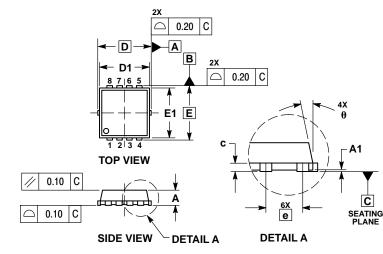


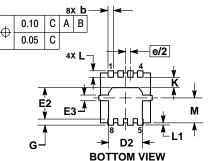
TYPICAL CHARACTERISTICS

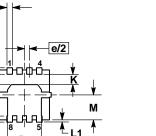


PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D







PROTRUSIONS OR GATE BURRS.

NOTES

2

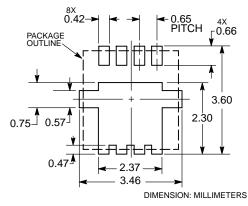
3.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC			.130 BSC)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	(0.026 BS0	2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
ĸ	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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